

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination GULLAPALLI ET AL.	
		Examiner Naum B. Levin	Art Unit 2825	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,705,409	12-1972	Brayton et al.	716/1
	B	US-6,154,716	11-2000	Lee, David C.	703/2
	C	US-6,530,065	03-2003	McDonald et al.	716/4
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Moradi et al. "An analytical method for noise analysis of a dual gate fet mixer", 2nd International Conference on Microwave Technology, 2000, IEEE, pp.92-95.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.